


<b>Search Notes</b>  	<b>Application/Control No.</b>  10512017	<b>Applicant(s)/Patent Under Reexamination</b>  BENETIK ET AL.
	<b>Examiner</b>  Kiesha L Rose	<b>Art Unit</b>  2822

SEARCHED			
Class	Subclass	Date	Examiner
257	303,296,298,300,301	1/4/09	TC

SEARCH NOTES		
Search Notes	Date	Examiner
Updated search	12/20/07	KLR
Updated text search	6/7/08	KLR
Updated search	1/4/09	TC
updated text search	10/12/09	TC
updated search	3/26/10	TC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	interference searched	3/26/10	TC

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